

Features

- N-Channel enhancement mode device
- DMOS structure
- Lower capacitances for broadband operation
- High saturated output power
- Lower noise figure than bipolar devices

ABSOLUTE MAXIMUM RATINGS AT 25° C

Parameter	Symbol	Rating	Units
Drain-Source Voltage	V_{DS}	65	V
Gate-Source Voltage	V_{GS}	20	V
Drain-Source Current	I_{DS}	12	A
Power Dissipation	P_D	250	W
Junction Temperature	T_J	200	°C
Storage Temperature	T_{STG}	-55 to +150	°C
Thermal Resistance	θ_{JC}	0.7	°C/W

TYPICAL DEVICE IMPEDANCE

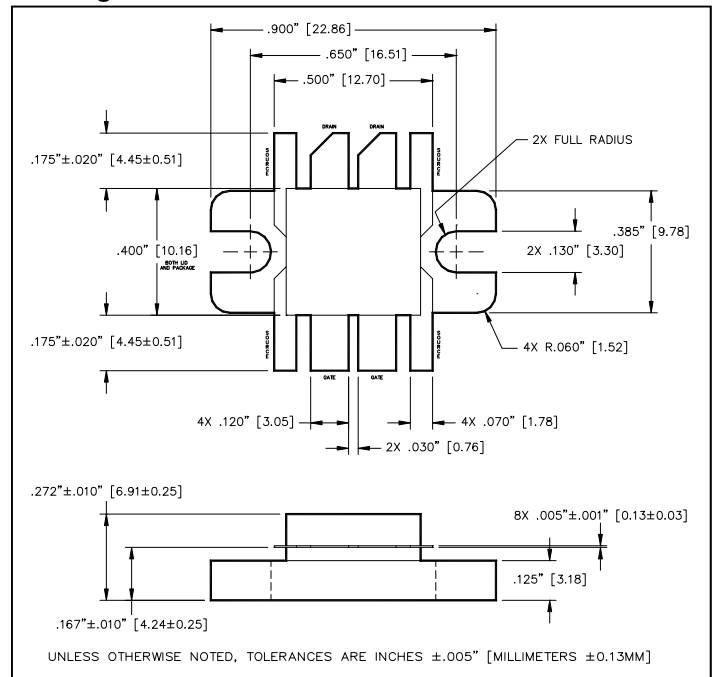
F (MHz)	Z_{IN} (Ω)	Z_{LOAD} (Ω)
30	3.0 - j12.5	8.0 + j6.0
50	1.5 - j8.5	7.0 + j6.5
100	1.0 - j6.0	6.5 + j5.0

$V_{DD} = 28V, I_{DQ} = 600mA, P_{OUT} = 120 W$

ELECTRICAL CHARACTERISTICS AT 25°C

Parameter	Symbol	Min	Max	Units	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	65	-	V	$V_{GS} = 0.0 V, I_{DS} = 3.0 mA$
Drain-Source Leakage Current	I_{DSS}	-	6.0	mA	$V_{GS} = 28.0 V, V_{DS} = 0.0 V$
Gate-Source Leakage Current	I_{GSS}	-	6.0	μA	$V_{GS} = 20.0 V, V_{DS} = 0.0 V$
Gate Threshold Voltage	$V_{GS(TH)}$	2.0	6.0	V	$V_{DS} = 10.0 V, I_{DS} = 600.0 mA$
Forward Transconductance	G_M	3.0	-	S	$V_{DS} = 10.0 V, I_{DS} = 6000.0 mA, \Delta V_{GS} = 1.0V, 80 \mu s$ Pulse
Input Capacitance	C_{ISS}	-	270	pF	$V_{DS} = 28.0 V, F = 1.0 MHz$
Output Capacitance	C_{OSS}	-	240	pF	$V_{DS} = 28.0 V, F = 1.0 MHz$
Reverse Capacitance	C_{RSS}	-	48	pF	$V_{DS} = 28.0 V, F = 1.0 MHz$
Power Gain	G_P	13	-	dB	$V_{DD} = 28.0 V, I_{DQ} = 600 mA, P_{OUT} = 120.0 W F = 175 MHz$
Drain Efficiency	η_D	60	-	%	$V_{DD} = 28.0 V, I_{DQ} = 600 mA, P_{OUT} = 120.0 W F = 175 MHz$
Return Loss	R_L	10	-	%	$V_{DD} = 28.0 V, I_{DQ} = 600 mA, P_{OUT} = 120.0 W F = 175 MHz$
Load Mismatch Tolerance	VSWR-T	-	30:1	-	$V_{DD} = 28.0 V, I_{DQ} = 600 mA, P_{OUT} = 120.0 W F = 175 MHz$

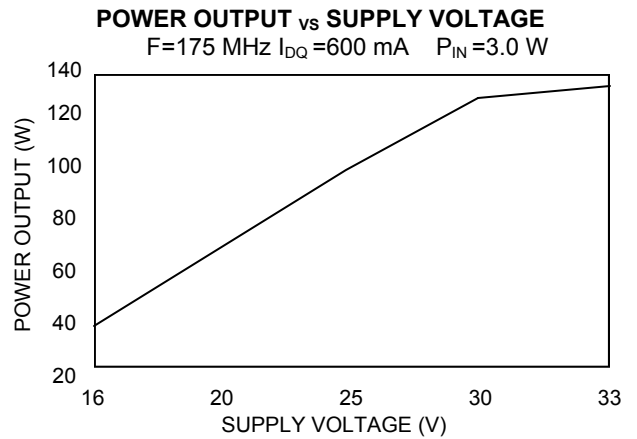
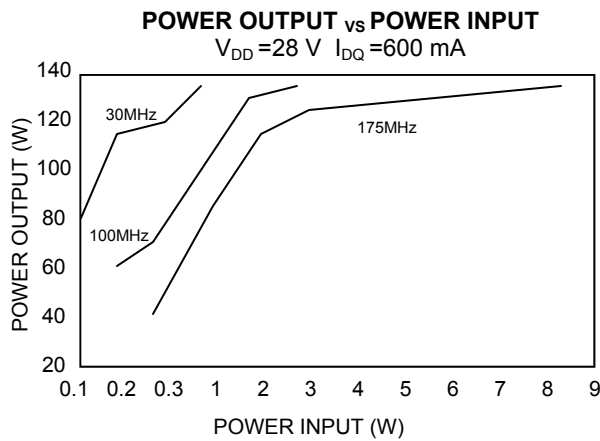
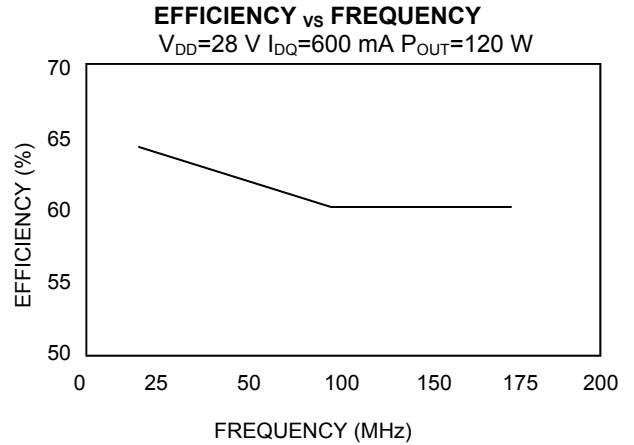
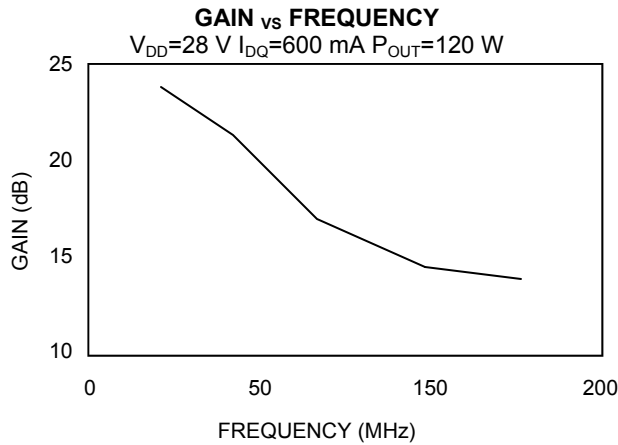
Package Outline



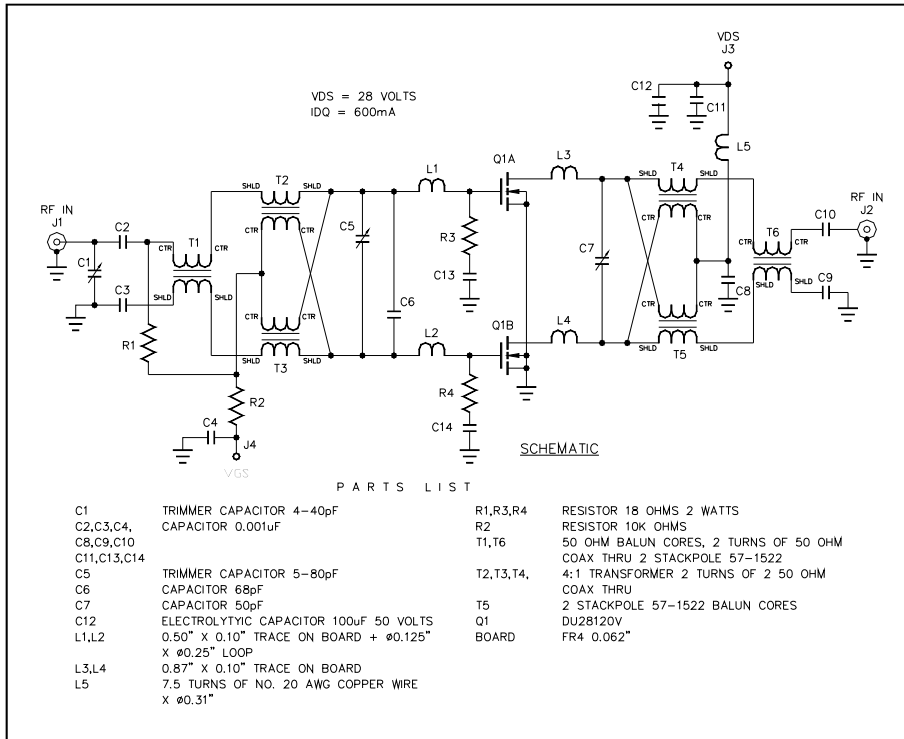
Z_{IN} is the series equivalent input impedance of the device from gate to source.

Z_{LOAD} is the optimum series equivalent load impedance as measured from drain to ground.

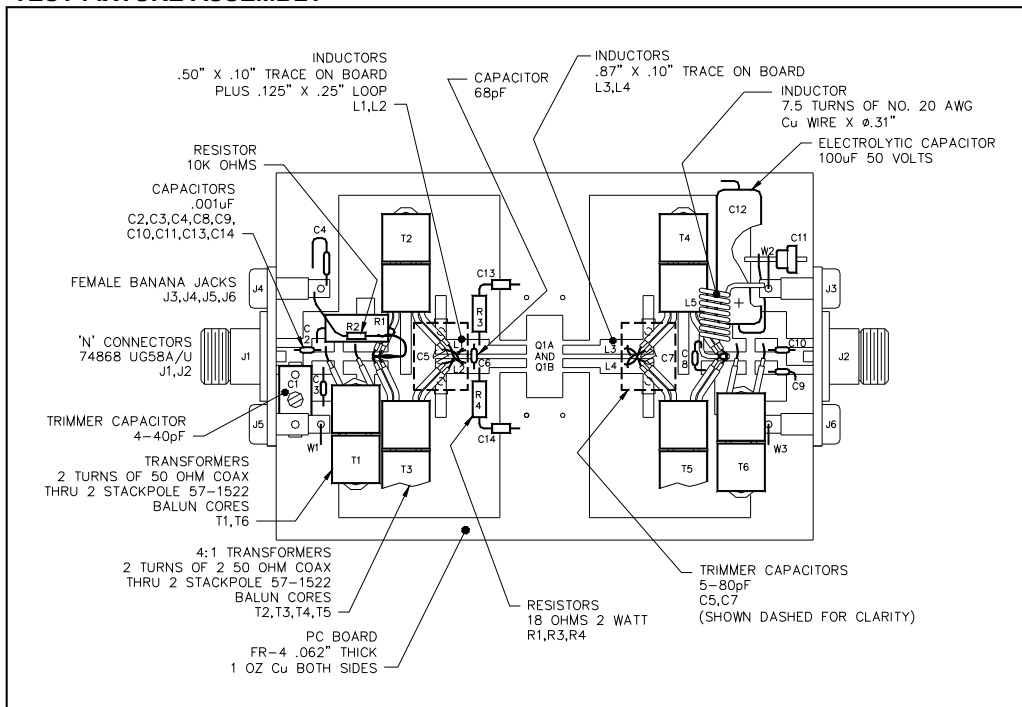
Typical Broadband Performance Curves



TEST FIXTURE SCHEMATIC



TEST FIXTURE ASSEMBLY



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